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ON Semiconductor[®]

FDC3612 100V N-Channel PowerTrench[®] MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $R_{DS(ON)}$ and fast switching speed.

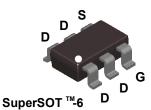
Applications

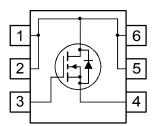
DC/DC converter

Features

FDC3612

- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- Low gate charge (14nC typ)
- High power and current handling capability
- Fast switching speed





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V _{DSS}	Drain-Source Voltage			100	V
V _{GSS}	Gate-Source	e Voltage		± 20	V
I _D	Drain Curre	nt – Continuous	(Note 1a)	2.6	A
		 Pulsed 		20	
E _{AS}	Single Pulse	e Avalanche Energy	(Note 3)	37 m	
P _D	Maximum Power Dissipation		(Note 1a)	1.6	W
			(Note 1b)	0.8	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			–55 to +150	
Therma R _{0JA}		teristics	Ambient (Note 1a)	78	°C/W
R _{ejc}	Thermal Resistance, Junction-to-Case		· · ·	30	°C/W
Packag		g and Orderin	g Information		
Device Marking		Device	Reel Size	Tape width	Quantity
.362		FDC3612	7"	8mm	3000 units

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Units Min T J Λ /[/] /⁰C Α Α Α Α //⁰C

FDC3612

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sc	Durce Avalanche Ratings (Note	2)			l	
W _{DSS}	Drain-Source Avalanche Energy	Single Pulse, V_{DD} = 50 V, I_D =2.6 A			90	mJ
I _{AR}	Drain-Source Avalanche Current				2.6	Α
Off Char	racteristics					
3V _{DSS} Drain–Source Breakdown Voltage		V _{GS} = 0 V, I _D = 250 μA	100			V
$\Delta BV_{DSS} \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		99		mV/°C
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			10	μA
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate–Body Leakage, Reverse	$V_{GS} = -20 V, V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	2	2.3	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		- 6		mV/°C
R _{DS(on)}	Static Drain–Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 2.6 \text{ A} \\ V_{GS} = 6.0 \text{ V}, I_D = 2.5 \text{ A} \\ V_{GS} = 10 \text{ V}, I_D = 2.6 \text{ A}; T_J = 125^{\circ}\text{C}$		86 91 157	125 135 240	mΩ
I _{D(on)}	On-State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V	10			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 2.6 \text{ A}$		10		S
Dvnamio	c Characteristics					
Ciss	Input Capacitance	$V_{DS} = 50 V$, $V_{GS} = 0 V$,		660		pF
C _{iss} C _{oss}	Input Capacitance Output Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1.0 MHz		660 55		pF pF
	· · ·					•
Coss	Output Capacitance		0.1	55	3.0	pF
C _{oss} C _{rss} R _g	Output Capacitance Reverse Transfer Capacitance Gate Resistance		0.1	55 40	3.0	pF pF
C _{oss} C _{rss} R _g Switchir	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2)	f = 1.0 MHz	0.1	55 40	3.0	pF pF
C _{oss} C _{rss} R _g Switchir t _{d(on)}	Output Capacitance Reverse Transfer Capacitance Gate Resistance		0.1	55 40 1.4	- <u> </u>	pF pF Ω
Coss Crss Rg Switchir t _{d(on)} tr	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time	f = 1.0 MHz V _{DD} = 50 V, I _D = 1 A,	0.1	55 40 1.4 6	11	pF pF Ω ns
C _{oss} C _{rss} R _g Switchir t _{d(on)}	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time Turn–On Rise Time	f = 1.0 MHz V _{DD} = 50 V, I _D = 1 A,	0.1	55 40 1.4 6 3.5	11 7	pF pF Ω ns
$\begin{array}{c} C_{oss} \\ \hline C_{rss} \\ \hline R_g \\ \hline \textbf{Switchir} \\ \hline t_{d(on)} \\ \hline t_r \\ \hline t_{d(off)} \\ \hline \end{array}$	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Delay Time	f = 1.0 MHz V _{DD} = 50 V, I _D = 1 A,	0.1	55 40 1.4 6 3.5 23	11 7 37	pF pF Ω ns ns
$\begin{array}{c} C_{oss} \\ \hline C_{rss} \\ \hline R_g \\ \hline \textbf{Switchir} \\ t_{d(on)} \\ \hline t_r \\ t_{d(off)} \\ \hline t_r \\ t_f \\ \end{array}$	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Delay Time Turn–Off Fall Time	f = 1.0 MHz V_{DD} = 50 V, I_D = 1 A, V_{GS} = 10 V, R_{GEN} = 6 Ω	0.1	55 40 1.4 6 3.5 23 3.7	11 7 37 7.4	pF pF Ω ns ns ns ns
$\begin{array}{c} \hline C_{oss} \\ \hline C_{rss} \\ \hline R_g \\ \hline \textbf{Switchir} \\ \hline \textbf{t}_{d(on)} \\ \hline t_r \\ \hline t_{d(off)} \\ \hline t_r \\ \hline q_g \\ \hline \end{array}$	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Delay Time Turn–Off Fall Time Total Gate Charge	f = 1.0 MHz $V_{DD} = 50 V$, $I_D = 1 A$, $V_{GS} = 10 V$, $R_{GEN} = 6 Ω$ $V_{DS} = 50 V$, $I_D = 2.6 A$,	0.1	55 40 1.4 6 3.5 23 3.7 14	11 7 37 7.4	pF pF Ω ns ns ns nc
Coss Crss Rg Switchir td(on) tr td(off) tf Qg Qgs Qgd	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Delay Time Turn–Off Fall Time Total Gate Charge Gate–Source Charge Gate–Drain Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 50 \text{ V}, \qquad I_D = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$ $V_{DS} = 50 \text{ V}, \qquad I_D = 2.6 \text{ A},$ $V_{GS} = 10 \text{ V}$	0.1	55 40 1.4 6 3.5 23 3.7 14 2.3	11 7 37 7.4	pF pF Ω ns ns ns nC nC
Coss Crss Rg Switchir t _{d(on)} tr t _{d(off)} t _f Qg Qgd Drain–So	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Delay Time Turn–Off Fall Time Total Gate Charge Gate–Source Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 50 \text{ V}, \qquad I_D = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$ $V_{DS} = 50 \text{ V}, \qquad I_D = 2.6 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Ratings	0.1	55 40 1.4 6 3.5 23 3.7 14 2.3	11 7 37 7.4	pF pF Ω ns ns ns nC nC
Coss Crss Rg Switchir td(on) tr td(off) tf Qg Qgs Qgd	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge ource Diode Characteristics Maximum Continuous Drain-Source Drain-Source Diode Forward	$f = 1.0 \text{ MHz}$ $V_{DD} = 50 \text{ V}, \qquad I_D = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$ $V_{DS} = 50 \text{ V}, \qquad I_D = 2.6 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Ratings	0.1	55 40 1.4 6 3.5 23 3.7 14 2.3	11 7 37 7.4 20	pF pF Ω ns ns ns nC nC nC
Coss Crss Rg Switchir ta(on) tr tq(off) tr Qg Qgd Drain–So	Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Delay Time Turn–Off Fall Time Total Gate Charge Gate–Source Charge Gate–Drain Charge ource Diode Characteristics Maximum Continuous Drain–Source	$f = 1.0 \text{ MHz}$ $V_{DD} = 50 \text{ V}, I_D = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ $V_{DS} = 50 \text{ V}, I_D = 2.6 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Ratings Diode Forward Current	0.1	55 40 1.4 6 3.5 23 3.7 14 2.3 3.6	11 7 37 7.4 20 1.3	pF pF Ω ns ns ns nc nC nC

 $T_A = 25^{\circ}C$ unless otherwise noted

Notes:

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $\rm R_{_{\theta JC}}$ is guaranteed by design while $\rm R_{_{\theta CA}}$ is determined by the user's board design.

a. 78° C/W when mounted on a $1in^2$ pad of 2oz copper on FR-4 board.

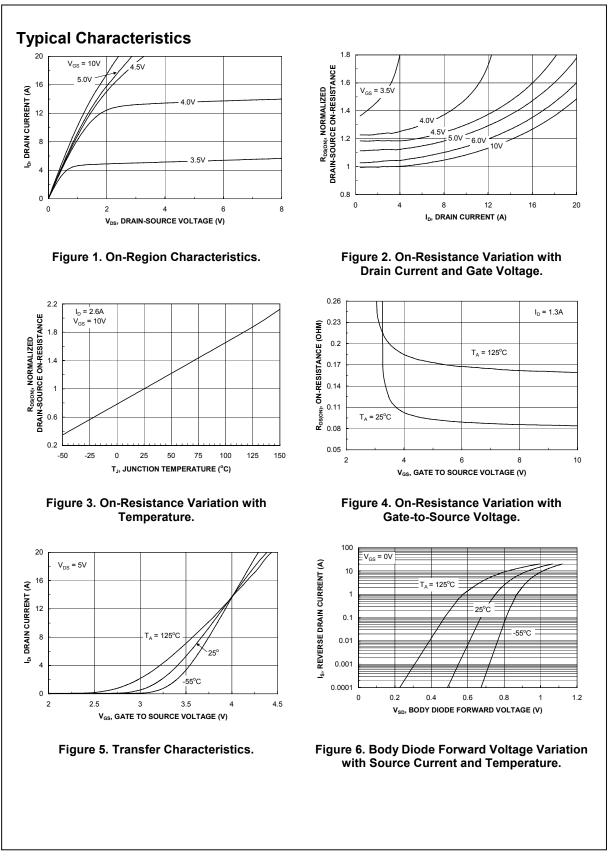
b. 156°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width \leq 300 $\mu s,$ Duty Cycle \leq 2.0%

Electrical Characteristics

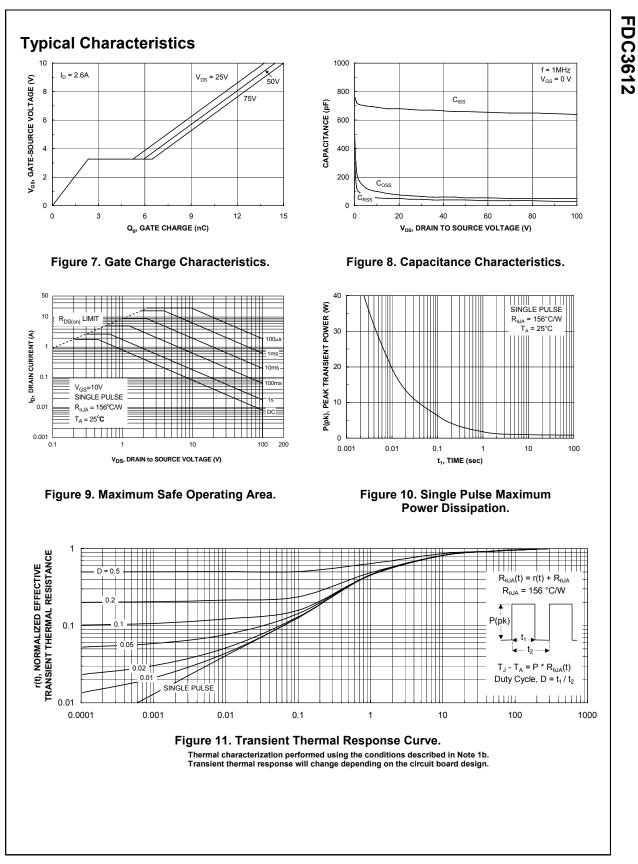
3. E_{AS} of 37 mJ is based on starting T_J = 25 °C; N-ch: L = 3 mH, I_{AS} = 5 A, V_{DD} = 100 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 11 A.

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